

Type-II Interface Band Alignment in the vdW PbI₂–MoSe₂ Heterostructure

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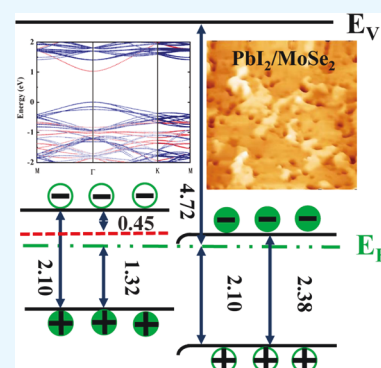
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Supporting Information

ABSTRACT: Energy band alignments at heterostructure interfaces play key roles in device performance, especially between two-dimensional atomically thin materials. Herein, van der Waals PbI₂–MoSe₂ heterostructures fabricated by *in situ* PbI₂ deposition on monolayer MoSe₂ are comprehensively studied using scanning tunneling microscopy/spectroscopy, atomic force microscopy, photoemission spectroscopy, and Raman and photoluminescence (PL) spectroscopy. PbI₂ grows on MoSe₂ in a quasi layer-by-layer epitaxial mode. A type-II interface band alignment is proposed between PbI₂ and MoSe₂ with the conduction band minimum (valence band maximum) located at PbI₂ (MoSe₂), which is confirmed by first-principles calculations and the existence of interfacial excitons revealed using temperature-dependent PL. Our findings provide a scalable method to fabricate PbI₂–MoSe₂ heterostructures and new insights into the electronic structures for future device design.

KEYWORDS: PbI₂, MoSe₂, vdW heterostructure, type II band alignment, Raman and PL spectroscopy



INTRODUCTION

Progress on van der Waals (vdW) heterostructures made of atomically thin transition metal dichalcogenides (TMDCs) has offered new electronic and optoelectronic applications, where energy band alignments at interfaces play key roles.^{1–4} Type-II band alignment (staggered gap) has extensive applications in photovoltaics and optoelectronics, attributed to the enhanced abilities of the photogenerated charge carriers to cross the interface because of the built-in electric field.^{5–7} In contrast, type-I and type-III (straddling gap and broken gap) band alignments are used for light-emitting and tunneling field effect transistors, respectively.^{8,9} Fabrication of vdW heterostructures with atomically and electronically sharp interfaces plays key roles in essential studies and applications.

Layered lead iodide (PbI₂) is a strong light adsorption and emission material, being widely used in lead halide perovskites^{10–12} and having good potential in optoelectronic applications.¹³ For instance, millimeter-sized freestanding PbI₂ flakes can be transferred and stacked on a single crystal antimony sulphoiodide whisker to form a high-performance 2D-1D vdW heterostructure photodetector.¹⁴ The 2D vdW heterostructure of PbI₂ and graphene is applicable to flexible or stretchable electronics.¹⁵ PbI₂ shows a transition from the direct band gap to indirect one when reduced to one monolayer,¹⁶ while the reverse is true for TMDCs such as MoS₂, MoSe₂, and MoTe₂. For PbI₂–TMDC vdW heterostructures, energy band alignments have been investigated recently using the PL method. The PbI₂–WS₂ heterostructure,

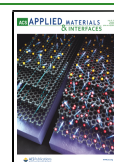
which is fabricated by a dry method to stack the exfoliated monolayer WS₂ on top of the multilayer PbI₂ single crystal flakes synthesized in solution, shows a type-II band alignment, whereas PbI₂–MoS₂ fabricated in the same method exhibits a type-I band alignment.¹⁷ On the contrary, the PbI₂–MoS₂ heterojunction *via* thermal deposition displays a type-II band alignment,¹⁸ in line with recent theoretical prediction.¹⁹ The two-step CVD-grown PbI₂–WS₂ and PbI₂–WSe₂ heterobilayers show a type-I and type-II band alignment, respectively.²⁰ Therefore, more research studies in this field are called for. Most heterostructures studied have been based on small micrometer-scale flakes using transfer technology. High quality and scalable production without transfer are required for commercial applications.

Molecular beam epitaxy (MBE) is the method of choice to prepare high-quality large-area monolayer MoSe₂,²¹ a promising semiconductor with a high mobility of over 120 cm² V^{–1} s^{–1} for (flexible) transistors.^{22,23} Herein, PbI₂ thin films were thermally deposited onto MBE-grown monolayer MoSe₂ under high-vacuum conditions to fabricate PbI₂–MoSe₂ vdW heterostructures. Scanning tunneling microscopy/spectroscopy

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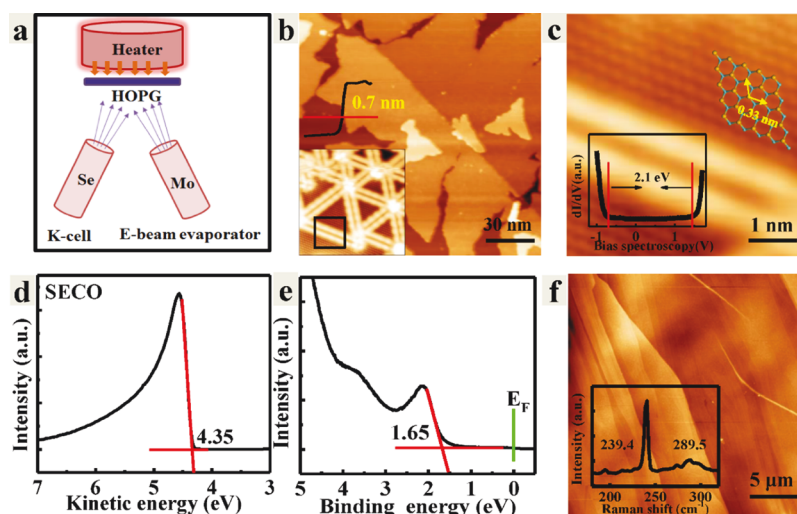


Figure 1. Characterization of the MBE-grown monolayer MoSe₂ on HOPG. (a) Schematic of the MBE growth of MoSe₂. (b) Large-scale STM image ($U_{\text{tip}} = -3.78$ V, $I = 10$ pA). The line profile shows a height of 0.7 nm. The inset zoom-in STM image shows the typical wagon-wheel patterns of MoSe₂ (size: 15×15 nm²; $U_{\text{tip}} = -1.3$ V, $I = 122$ pA). (c) Atomic-resolution STM image ($U_{\text{tip}} = -1.3$ V, $I = 122$ pA) overlapped by a ball-and-stick model, showing a lattice constant of ~ 0.33 nm. Se (Mo) atoms are shown in orange (green). The inserted STS spectrum ($U_{\text{tip}} = -0.7$ V, $I = 50$ pA) reveals a band gap of ~ 2.1 eV. (d,e) SECO and valence band structure, respectively. (f) AFM image showing an atomically smooth surface. Inset: typical Raman spectrum.

(STM/STS), atomic force microscopy (AFM), photoemission spectroscopy (PES), and Raman and photoluminescence (PL) spectroscopy measurements were conducted to investigate them. AFM results disclose the layered structure of PbI₂ on MoSe₂. Raman and XPS results reveal the stability of MoSe₂ and PbI₂–MoSe₂ heterostructures in air. Ultraviolet photoelectron spectroscopy results reveal that a type-II energy band alignment in vertical PbI₂–MoSe₂ vdW heterostructures is formed. First-principles calculations and PL measurements further confirm the type-II band alignment.

METHODS

Sample Preparation. MBE-grown monolayer MoSe₂ samples were prepared on HOPG substrates in an ultrahigh vacuum (UHV) chamber with a base pressure of $\sim 1 \times 10^{-9}$ mbar,^{24,25} as illustrated in Figure 1a. Se (Sigma, 99.999%) was evaporated from a K-cell at 470 K, while Mo (ESPI Metals, 99.999%) was evaporated from an e-beam evaporator. To ensure sufficient Se atoms to react with Mo, the HOPG substrate was held at a temperature of 620 K under Se-rich conditions. Following MBE growth, the sample was capped with a ~ 15 nm-thick Se layer. For subsequent STM/STS and PES characterization and PbI₂ deposition, the capped sample was annealed at 520 K for 2 h for the purpose of complete removal of the Se capping layer. Atomically thin MoSe₂ flakes were mechanically exfoliated from the bulk crystals (Shanghai Onway Technology Co., Ltd) onto 300 nm SiO₂/Si substrates using the Scotch tape method.²⁶ Their thicknesses were identified by optical microscopy (OM) and Raman spectroscopy.²⁷ Sublimation-purified PbI₂ (Aldrich, 98+ %) was evaporated from a K-cell in an high vacuum chamber with a base pressure of 1.0×10^{-7} mbar, where a quartz microbalance is equipped to monitor the deposited PbI₂ film thickness.^{18,28} The nominal deposition rate of PbI₂ was calibrated to be 1.0 nm/min at a deposition temperature of ~ 600 K.

Measurements. STM/STS measurements were carried out at 77 K in a custom-built multichamber UHV system housing an Omicron LT-STM instrument with a base pressure better than 6.0×10^{-11} mbar in the surface science laboratory at the NUS.²⁴ STM images were acquired in the constant current mode and bias voltages were applied to the tip. PES measurements were implemented in a spectrometer chamber (base pressure: 2.0×10^{-10} mbar) equipped with a SPECS PHOIBOS150 hemispherical energy analyzer, a

monochromatic SPECS XR-MF X-ray source (Al K α , $h\nu = 1486.7$ eV), and a SPECS microwave UV light source (He I α , $h\nu = 21.2$ eV).^{29,30} Raman and PL measurements were performed in an inVia Qontor system (Renishaw, UK) using a 532 nm laser with a spot size less than $1 \mu\text{m}$ and a 1800 lines/mm grating.³¹ OM measurements were carried out in a CaiKang DMM-200C optical microscope. AFM images were captured with a 5500 SPM system (Agilent, USA) in the tapping mode.³² Except for STM/STS measurements at liquid nitrogen temperature (77 K), all other measurements were performed at RT.

Density Functional Theory Calculations. The first-principles calculations based on density functional theory were performed with Vienna Ab initio Simulation Package (VASP).^{33,34} The projector-augmented wave pseudopotential and Perdew–Burke–Ernzerhof exchange–correlation functional were used. The energy cutoff of the plane-wave basis was set as 400 eV.^{35,36} The vacuum thickness was set to be larger than 15 Å. For the heterostructure, a 2×2 lattice of the PbI₂ monolayer is placed on a 3×3 lattice of the MoSe₂ monolayer. The first Brillouin Zone (BZ) was sampled with a gamma-centered k-mesh. A $6 \times 6 \times 1$ k-mesh is used for structural optimization and self-consistent calculations because of the larger supercell. To determine the partial occupancies for each orbital, Gaussian smearing with a width of 0.05 eV was used. The convergence of the force on each atom to optimize their positions was less than 0.01 eV/Å. The convergence condition of the electronic self-consistent loop was 10^{-5} eV. Additionally, spin–orbit coupling (SOC) was included in the electronic self-consistent loop and band structure calculation.³⁷

RESULTS AND DISCUSSIONS

The representative large-scale STM image in Figure 1b shows that the as-grown MoSe₂ flakes appear as leaf-like islands on HOPG with a height of ~ 0.7 nm (line profile), indicating its monolayer thickness. A few bilayer islands form because of kinetic causation during MBE growth.³⁸ The inserted zoom-in STM image shows wagon-wheel patterns formed by mirror twin boundaries (MTBs), which are ascribed to the one-dimensional Se defects.³⁹ Figure 1c shows an atomic-resolution STM image of the black square region in panel b. The atomic features with a lattice constant of 0.33 nm are assigned as the upper-layer Se atoms in the hexagonal lattice of MoSe₂. To

guide the eye, a piece of the ball-and-stick lattice model is overlapped with Se (Mo) atoms in orange (green). The inserted STS spectrum obtained in the region away from MTBs reveals an energy band gap of ~ 2.10 eV, consistent with previous reports.^{40,41} The valence band maximum (VBM) and conduction band minimum (CBM) are located at 1.45 and -0.65 eV, respectively, suggesting its n-type semiconducting nature. This can be attributed to intrinsic point defects such as vacancies or lattice antisites and doping from the underlying substrate.⁴² Because of the additional nonradiative channels that are opened by the highly-conductive HOPG substrate which both reduces the overall PL signal and the quasiparticle lifetime,⁴¹ no band-edge PL emissions of MoSe₂/HOPG were detected, in consistence with previous report.³⁸ In contrast, an optical band gap of 1.57 eV is detected under the same experimental presetting conditions on mechanically exfoliated monolayer MoSe₂ flakes (*cf.* Figure 5).

The secondary electron cutoff (SECO) of monolayer MoSe₂ on HOPG (Figure 1d) reveals a work function (WF) of ~ 4.35 eV. The VBM of MoSe₂ (Figure 1e) is measured to be ~ 1.65 eV below the Fermi level (E_F), confirming its n-type semiconducting nature, consistent with our STS results. Measurements in air were also performed after Se capping layer removal to confirm the high quality and ambient stability of MoSe₂. The corresponding AFM image in Figure 1f shows the atomically smooth surface. In contrast, the AFM image of as-received MoSe₂ in Figure S1a shows randomly distributed protrusions. The corresponding Mo 3d and Se 3d core level XPS spectra (Figure S1b,c) confirm that the Se capping layer has desorbed thoroughly. The typical Raman spectrum in Figure 1f clearly shows two characteristic peaks at 239.4 and 289.5 cm^{-1} , which arise from the out-of-plane vibration mode of Se atoms (A_{1g}) and in-plane vibration of Mo and Se atoms (E_{2g}^1), respectively.^{43,44} As shown in Figure S2, the full width at half maximum of the A_{1g} peak of MBE-grown monolayer MoSe₂ (4.2 cm^{-1}) is similar to that of exfoliated monolayer MoSe₂ (3.9 cm^{-1}), verifying their same high quality.

Upon nominal 3 nm-thick PbI₂ deposition, the samples were *ex situ*-characterized using AFM, Raman, XPS, and PL. The typical AFM image (Figure 2a) shows similar terrace features as in Figure 1f but rougher. This suggests that at RT, the vdW epitaxial growth of PbI₂ on MoSe₂ is not as perfect as that on MoS₂.¹⁸ A typical zoomed-in AFM image in Figure 2b and the profile (insert) show that single-layered islands with smooth surfaces start to grow on the uncompleted PbI₂ layers, indicating a quasi layer-by-layer vdW epitaxial growth mode of PbI₂ on MoSe₂ at RT. The Raman spectrum in Figure 2a inset shows both the MoSe₂-related and PbI₂-related peaks. The MoSe₂-related characteristic peak A_{1g} blue-shifts by 0.2 to 239.6 cm^{-1} and E_{2g}^1 red-shifts by 0.4 to 289.1 cm^{-1} . The A_{1g} frequency increases with layer numbers mainly because of the enlarged interlayer interaction, while the E_{2g}^1 frequency decreases because of the increased dielectric screening and the reduced overall restoring force on the atoms.^{45–48} The first possible reason for the abovementioned shift is that the deposited PbI₂ caused interlayer coupling. Second, A_{1g} is sensitive to electron–phonon coupling at the interface, while E_{2g}^1 is sensitive to the built-in strain.⁴⁹ The P-doping can lead E_{2g}^1 and A_{1g} modes red- and blue-shift, respectively.⁵⁰ A second possible reason is the interfacial charge transfer from MoSe₂ to PbI₂. PbI₂-related Raman peaks located at 70.1, 94.1, and 108.1 cm^{-1} are identified to the in-plane E_g' , the out-of-plane A_{1g} , and the infrared-active A_{2u} modes, respectively.⁵¹

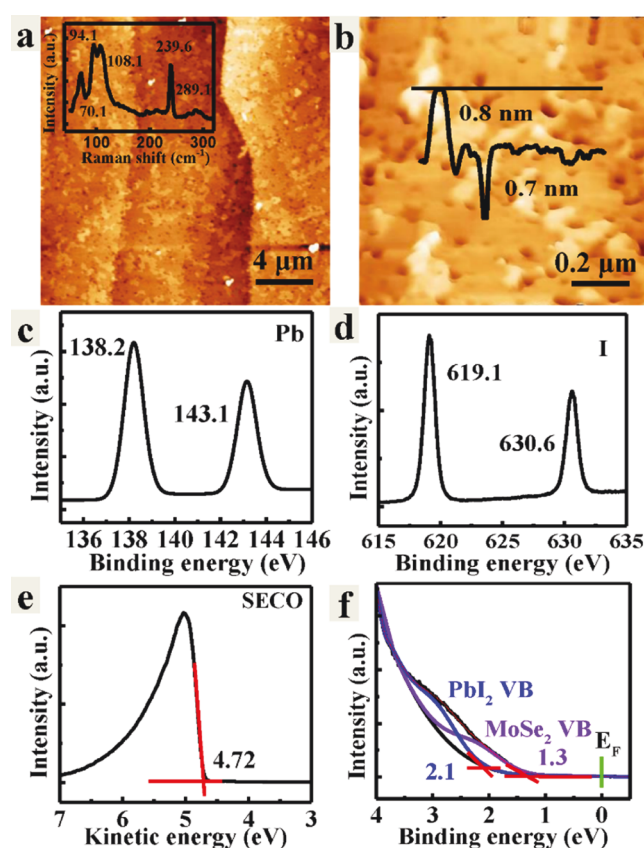


Figure 2. Characterization of the 3 nm-thick PbI₂–MoSe₂ vdW heterostructure. (a) Typical AFM image showing similar terrace features as the clean sample but rougher. The inserted Raman spectrum confirms the presence of PbI₂ and MoSe₂. (b) Amplified 3D AFM image and profile indicating a quasi layer-by-layer growth mode of PbI₂ on MoSe₂. (c,d) Pb 4f and I 3d core level XPS spectra, respectively. (e,f) SECO and valence band structure, respectively.

To further understand the chemical states of PbI₂, high-resolution XPS spectra of Pb 4f and I 3d were collected (Figure 2c,d, respectively). The peaks at 138.2 and 143.1 eV (619.1 and 630.6 eV) are assigned to Pb 4f_{7/2} and Pb 4f_{5/2} (I 3d_{5/2} and I 3d_{3/2}), respectively. The Pb/I ratio is calculated to be 1:1.9. The WF is measured to be 4.72 eV (Figure 2e) and the VBM is at ~ 1.32 eV below E_F (Figure 2f). This is inconsistent with our previous report that vapor-grown PbI₂ is heavily n-doped.¹⁸ Because of the higher WF of PbI₂–MoSe₂ (4.72 eV) than that of MoSe₂ (4.35 eV), electron transfer from MoSe₂ to PbI₂ is expected at the interface, causing PbI₂ to be further n-doped. Thus, the VBM of MoSe₂ (PbI₂) will shift upward (downward). Because of the semimetallic nature of HOPG and the monolayer thickness of MoSe₂, no bending but a rigid shift of the MoSe₂ energy bands is expected upon PbI₂ deposition. Thus, we assign the band onset at 1.32 eV to the VBM of MoSe₂ rather than to that of PbI₂. Figure 2f shows a second peak centered at ~ 2.6 eV below E_F , similar to our previous report.¹⁸ The onset of this band located at 2.1 ± 0.1 eV is assigned to the VBM of PbI₂.

According to the abovementioned results, the energy band diagrams of MoSe₂ and PbI₂–MoSe₂ are proposed in Figure 3a,b, respectively. MBE-grown MoSe₂ on HOPG is an n-type semiconductor with the VBM at 1.65 eV below E_F . Upon PbI₂ deposition, the VBM of monolayer MoSe₂ shifts rigidly to 1.32 eV because of electron transfer to PbI₂. For the same reason,

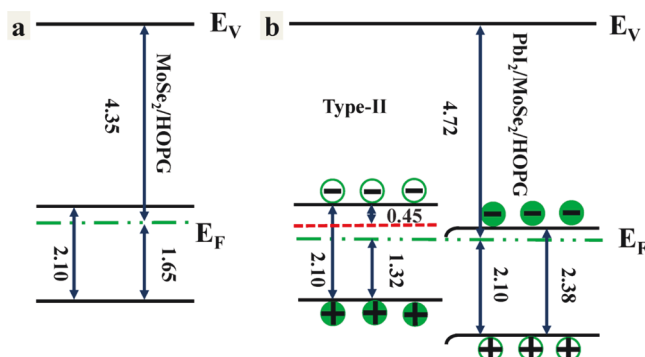


Figure 3. Energy band diagrams of MoSe₂ before (a) and after (b) PbI₂ deposition. The red-dashed line in (b) highlights the energy level of 1s exciton.

the bands of PbI₂ films bend downward at the interface. Such band bending will lower the VBM of PbI₂ films and enhance the band offset between MoSe₂ and PbI₂, as shown in Figure 3b. Thus, a type-II band alignment is formed at the interface. According to the previously reported PL peak of MoSe₂ on HOPG being at 1.65 ± 0.02 eV at liquid nitrogen temperature,^{41,52} the MoSe₂ 1s exciton binding energy is calculated to be 0.45 ± 0.02 eV, highlighted by the red-dashed line in Figure 3b. The CBM of PbI₂ remains lower than the 1s exciton of MoSe₂, which is beneficial to the formation of interfacial exciton. Thus, photogenerated electrons in MoSe₂ will spontaneously transfer to the CBM of PbI₂, resulting in PL quenching of monolayer MoSe₂. To verify this hypothesis, first-principles calculations and PL measurements on PbI₂–MoSe₂ (exfoliated monolayer) were performed.

Figure 4 shows the first-principles calculated results. The in-plane lattice constants of MoSe₂ and PbI₂ are 3.33 and 4.69 Å, respectively. Both have hexagonal symmetry. To minimize the lattice mismatch between the stacked MoSe₂ and PbI₂, 2×2 PbI₂ cells and 3×3 MoSe₂ cells were adopted to build the supercell, whose overall lattice mismatch in PbI₂ and MoSe₂ lattices are 5.2 and 0.9%, respectively. The lattice constant of the heterostructure is closer to that of the 3×3 MoSe₂ cells. Figure 4a shows the side and top views of the PbI₂–MoSe₂ heterostructure. The separation between them is calculated to be 7.64 Å, confirming the vdW interfacial interaction. Figure 4b shows the corresponding projected band structure. The band gap is calculated to be 1.029 eV with both CBM and VBM at the Γ point, indicating a direct band gap. The blue and red bands are from MoSe₂ and PbI₂, respectively. The CBM

and VBM of the PbI₂–MoSe₂ heterostructure are located at PbI₂ and MoSe₂, respectively, indicating a type-II band alignment. It is well-known that indirect to direct band gap transition occurs when the thickness of PbI₂ increases from monolayer to bulk. Our calculated results show that for thicker PbI₂ on monolayer MoSe₂, the band gap remains direct but slightly smaller. Figure S3 shows the calculated results for the heterostructure of four layers of PbI₂ and one layer of MoSe₂. The type-II band alignment is enhanced.

Figure 5 shows the Raman (a) and PL (b) spectra of exfoliated monolayer MoSe₂ flakes before and after 3 nm-thick

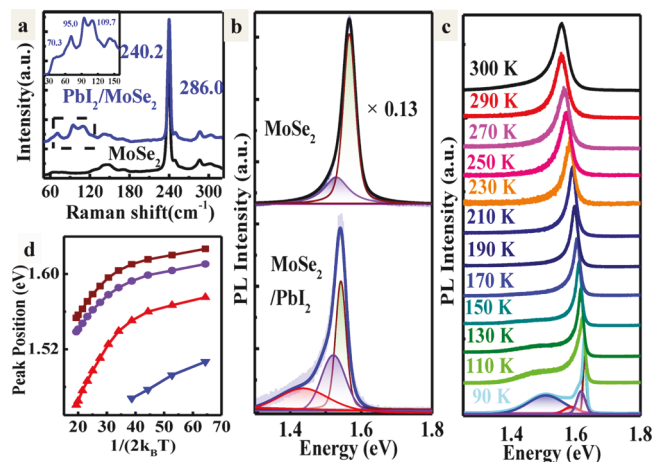


Figure 5. PbI₂ on exfoliated MoSe₂. (a) Raman and (b) PL spectra of monolayer MoSe₂ before and after PbI₂ deposition. (c) Temperature-dependent PL spectra of the PbI₂–MoSe₂ vdW heterostructure from 90 to 300 K. (d) Plotted PL peak position evolutions as a function of temperature.

PbI₂ deposition. The corresponding morphologies are shown in Figure S4. The Raman spectra show similar features as those in Figure 1f (MoSe₂) and Figure 2a (PbI₂–MoSe₂), confirming the formation of high quality PbI₂–MoSe₂ heterostructures. The upper panel in Figure 5b shows the PL spectrum of exfoliated monolayer MoSe₂ flakes, which can be fitted by two peaks at 1.57 (A⁰) and 1.52 eV (A[−]). Upon PbI₂ deposition, the emission intensity is obviously lowered to about one over seven of that of as-exfoliated MoSe₂ flakes, consistent with the above-discussed type-II interface band alignment. Furthermore, to fit the PL spectrum, one more peak is required at ~ 1.43 eV, which is assigned to the interlayer excitons instead

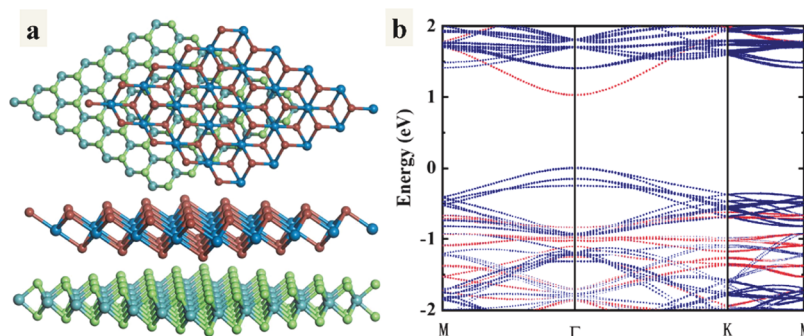


Figure 4. First-principles calculations on the PbI₂–MoSe₂ heterostructure. (a) Top and side views of the PbI₂–MoSe₂ heterostructure. (b) Calculated projected band structure of the PbI₂–MoSe₂ heterostructure with SOC. The bands plotted in blue and red are dominated by MoSe₂ and PbI₂, respectively.

of new tail states induced by PbI_2 or MoSe_2 below-gap states.¹⁸ The corresponding optical band gap is consistent with that in our proposed energy band diagrams in Figure 3b. Figure 5c shows the temperature-dependent PL spectra of the PbI_2 – MoSe_2 vdW heterostructure from 90 to 300 K. At 90 K, the defect-bounded exciton-related peak^{53,54} is observed at 1.51 eV with a binding energy of 0.12 eV, which disappears at 150 K and above. The corresponding PL spectrum fitting details are shown in Figure S5. As shown in Figure 5d, all the intrinsic three peaks red-shift with the temperature increasing. According to conventional semiconductor theory,⁵⁵ it can be ascribed to the stronger electron–phonon interaction and the slight bonding length enlargement.⁵⁶ The standard semi-conducting band gap model perfectly fits the dependence of all the intrinsic three peaks on temperature, as discussed in the Supporting Information.

CONCLUSIONS

In summary, we have systematically investigated the growth and electronic structures of PbI_2 –monolayer MoSe_2 heterostructures. AFM results reveal a quasi layer-by-layer vdW epitaxial growth mode of PbI_2 on MoSe_2 . A type-II energy band alignment at the interface of PbI_2 – MoSe_2 is proposed and verified by first-principles calculations and the existence of interfacial excitons. The results of this work provide a deeper understanding of the vertical PbI_2 – MoSe_2 heterostructure, which is important for future electronic device design.

ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge at <https://pubs.acs.org/doi/10.1021/acsami.0c04985>.

As-received MoSe_2 before and after removing the Se capping layer, Results on exfoliated monolayer MoSe_2 , Projected band structure of the heterostructure consists of four layers of PbI_2 and one layer of MoSe_2 , and Fittings of PL peaks (PDF)

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Notes

The authors declare no competing financial interest.

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